S	earci	h Note	es

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,963	· KAWAJI ET AL.	
Examiner	Art Unit	
Patrick Miller	2837	

SEARCHED			
Class	Subclass	Date	Examiner
318	801,802,8 11,729,43 8,52,713	5/28/2005	РМ
,			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
318	801,802	5/28/2005	PM
318	811,729	5/28/2005	РМ
318	438,52	5/28/2005	РМ
318	/812	5/28/2005	РМ

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
beat/slip/alias frequency; pn/positive neutral/dc bus; current detector	5/28/2005	РМ	
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